# onsemi

# <u>Silicon Carbide (SiC)</u> <u>MOSFET</u> – EliteSiC, 29 mohm, 1200 V, M3S, D2PAK-7L

# NTBG030N120M3S

#### Features

- Typ.  $R_{DS(on)} = 29 \text{ m}\Omega @ V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge ( $Q_{G(tot)} = 107 \text{ nC}$ )
- High Speed Switching with Low Capacitance ( $C_{oss} = 106 \text{ pF}$ )
- 100% Avalanche Tested
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb Free 2LI (on second level interconnection)

Typical Applications

- Solar Inverters
- Electric Vehicle Charging Stations
- UPS (Uninterruptible Power Supplies)
- Energy Storage Systems
- SMPS (Switch Mode Power Supplies)

#### MAXIMUM RATINGS (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	1200	V
Gate-to-Source Voltage			V <sub>GS</sub>	-10/+22	V
Continuous Drain Current (Notes 2, 3)	Steady State	$T_C = 25^{\circ}C$	۱ <sub>D</sub>	77	A
Power Dissipation (Note 2)			P <sub>D</sub>	348	W

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#### THERMAL CHARACTERISTICS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	0.43	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{\thetaJA}$	40	

#### RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value	Unit
Operation Values of Gate-to-Source Voltage	V <sub>GSop</sub>	-53 +18	V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

#### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Symbol	Test Condition	Min	Тур	Max	Unit			
OFF-STATE CHARACTERISTICS								
V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D = 1 mA$	1200	-	_	V			
V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, referenced to 25°C (Note 7)	-	0.3	-	V/°C			
I <sub>DSS</sub>	$V_{GS} = 0 V, V_{DS} = 1200 V$	-	-	100	μΑ			
I <sub>GSS</sub>	$V_{GS}$ = +22/-10 V, $V_{DS}$ = 0 V	-	I	±1	μΑ			
	Symbol V <sub>(BR)DSS</sub> V <sub>(BR)DSS</sub> /TJ I <sub>DSS</sub> I <sub>GSS</sub>	SymbolTest Condition $V_{(BR)DSS}$ $V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$ $V_{(BR)DSS}/T_J$ $I_D = 1 \text{ mA}, \text{ referenced to } 25^{\circ}C$ (Note 7) $I_{DSS}$ $V_{GS} = 0 \text{ V}, V_{DS} = 1200 \text{ V}$ $I_{GSS}$ $V_{GS} = +22/-10 \text{ V}, V_{DS} = 0 \text{ V}$	Symbol         Test Condition         Min $V_{(BR)DSS}$ $V_{GS} = 0 V$ , $I_D = 1 mA$ 1200 $V_{(BR)DSS}/T_J$ $I_D = 1 mA$ , referenced to 25°C (Note 7)         - $I_{DSS}$ $V_{GS} = 0 V$ , $V_{DS} = 1200 V$ - $I_{GSS}$ $V_{GS} = +22/-10 V$ , $V_{DS} = 0 V$ -	Symbol         Test Condition         Min         Typ $V_{(BR)DSS}$ $V_{GS} = 0 V$ , $I_D = 1 mA$ 1200         - $V_{(BR)DSS}/T_J$ $I_D = 1 mA$ , referenced to 25°C         -         0.3 $I_{DSS}$ $V_{GS} = 0 V$ , $V_{DS} = 1200 V$ -         - $I_{GSS}$ $V_{GS} = +22/-10 V$ , $V_{DS} = 0 V$ -         -	Symbol         Test Condition         Min         Typ         Max $V_{(BR)DSS}$ $V_{GS} = 0 \ V, \ I_D = 1 \ mA$ 1200         -         - $V_{(BR)DSS}/T_J$ $I_D = 1 \ mA, \ referenced \ to \ 25^{\circ}C \ (Note \ 7)$ -         0.3         - $I_{DSS}$ $V_{GS} = 0 \ V, \ V_{DS} = 1200 \ V$ -         -         100 $I_{GSS}$ $V_{GS} = +22/-10 \ V, \ V_{DS} = 0 \ V$ -         -         ±1			

Coto Thusehold Valters	$\mathcal{M}$	$V_{GS} = V_{DS}, I_D = 15 \text{ mA}$	2.04	2.4	4.4	V
	rDS(on)	v <sub>GS</sub> <del>= 18</del> V, I <sub>D</sub> = 30 A, T <sub>J</sub> = 25°C	1	29	39	mΩ
		V <sub>GS</sub> = 18 V, I <sub>D</sub> = 30 A, T <sub>J</sub> = 175°C (Note 7)	-	58	-	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 30 A (Note 7)	-	30	-	S

#### CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	C <sub>ISS</sub>	$V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 800 V	-	2430	-	pF
Output Capacitance	C <sub>OSS</sub>		-	106	-	
Reverse Transfer Capacitance	C <sub>RSS</sub>		-	9.4	-	
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -3/18 \text{ V}, \text{ V}_{DS} = 800 \text{ V},$	-		-	-

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#### D<sup>2</sup>PAK7 (TO-263-7L HV) CASE 418BJ ISSUE B

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DATE 16 AUG 2019



\*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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